


<b>Search Notes</b> 	<b>Application/Control No.</b> 10537043	<b>Applicant(s)/Patent Under Reexamination</b> LIAN ET AL.
	<b>Examiner</b> AKELAW A. TESHAE	<b>Art Unit</b> 2614

SEARCHED			
Class	Subclass	Date	Examiner
379	219	1/31/2009	AT
379	221.08	1/31/2009	AT
379	221.09	1/31/2009	AT
379	219, 221.08, 221.09	7/29/2009	AT
379	219, 221.08, 221.09	1/15/2010	AT
379	219, 221.08, 221.09	7/27/2010	AT
379	219, 221.08, 221.09	10/12/2010	AT

SEARCH NOTES		
Search Notes	Date	Examiner
Key Words: Intelligent network, advance network, next generation network, INAP	1/31/2009	AT
Inventor name search(east)	1/31/2009	AT
east search (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)	1/31/2009	AT
Please see east search attachment	1/31/2009	AT
Inventor name search(east)	7/28/2009	AT
east search (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)	7/28/2009	AT
Inventor name search(east)	1/15/2010	AT
east search (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)	1/15/2010	AT
Advised with Simon Sing	1/13/2010	AT
Please see east search attachment	1/16/2010	AT
Inventor name search(east)	7/26/2010	AT
east search (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)	7/26/2010	AT
Inventor name search(east)	10/12/2010	AT
east search (US-PGPUB;USPAT;USOCR;FPRS;EPO;JPO;DERWENT;IBM_TDB)	10/12/2010	AT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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